

U.S. UTILITY Patent Application

O.I.P.E.

PATENT DATE

<b>APPLICATION NO.</b> 09/909658	CONT/PRIOR	CLASS 324 714	SUBCLASS 727	2858 2133	EXAMINER Abrachan
Chandrase		nivasaiah	R 50		

Udupi Harisharan Chidambaram Ramaswamy

Boundary scan cell for testing AC coupled line using phase modulation technique in si

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	ISSUING CLASSIFICATION											
ORIGINAL					CROSS REFERENCE(S)							
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TERMINAL	- 4 ·	DRAWINGS		CLAIMS ALLOWED				
DISCLAIMER	Sheets Drwg.	Figs. Drwg.	Print Fig.	Total Claims	Print Claim for O.G.			
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